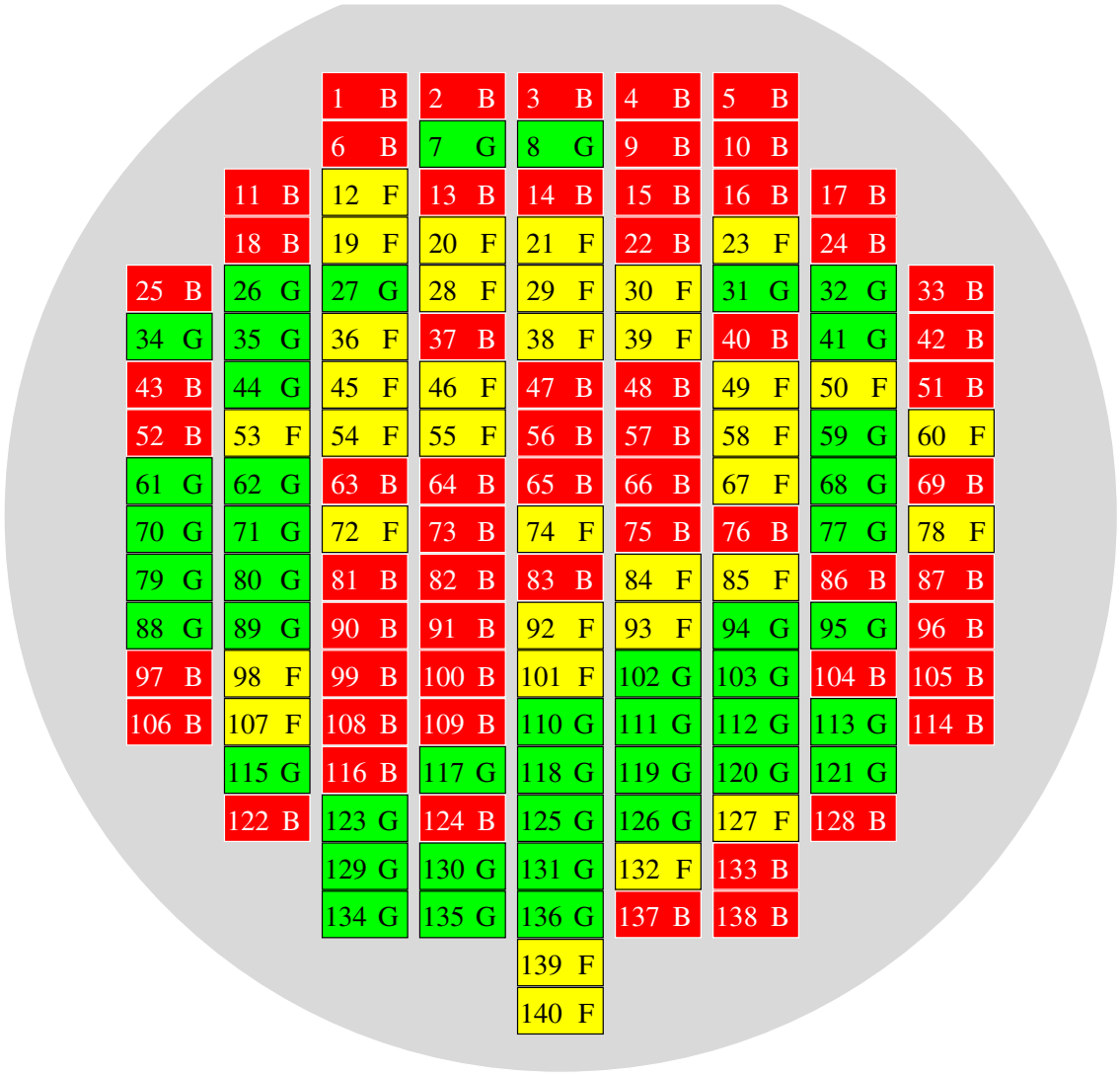
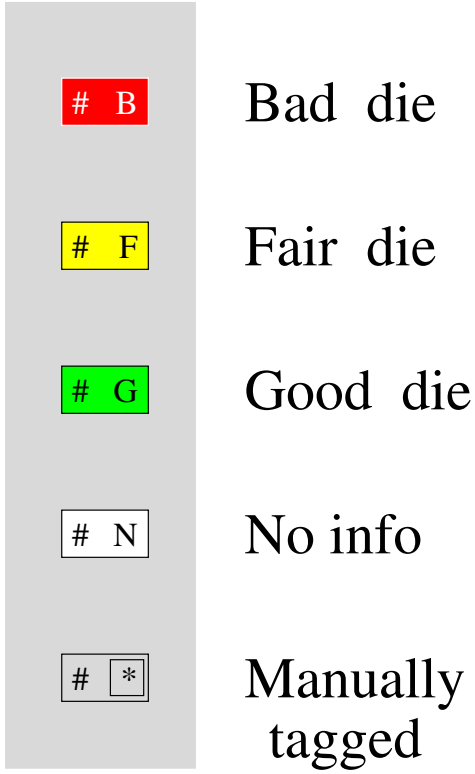
Die quality map for wafer 140 s/n: Y21316-08-17 (annealed)

Date: 06/04/99